

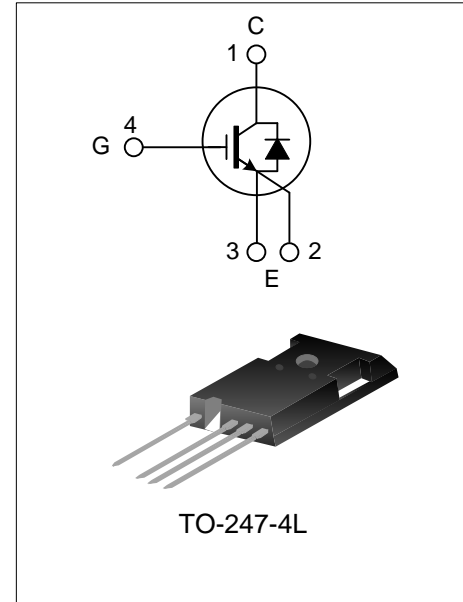
75A, 650V FIELD STOP IGBT

DESCRIPTION

SGT75T65SDM1P4 adopts Field Stop III IGBT technology, offer the optimum performance for induction Heating, UPS, SMPS and PFC application.

FEATURES

- ◆ 75A, 650V, $V_{CE(sat)(typ.)}=1.65V@I_C=75A$
- ◆ Low conduction loss
- ◆ Fast switching
- ◆ High input impedance



NOMENCLATURE

SGT 75 T 65 S D M 1 P4		
IGBT series	SGT	Package
Current, 70: 70A	75	P7 : TO-247-3L
N : N Channel	T	F : TO-220F-3L
NE : N-channel planar gate with ESD	65	1,2,3... : Version No.
T : Field Stop 3/4	S	Blank: Standard diode
U : Field Stop 4+	D	M : Standard Diode, full range
V : Field Stop 5	M	R : Rapid Diode
W : Field Stop 6	1	B : Rapid Diode, full range
X : Field Stop 7	P4	S : Soft Diode, full range
Voltage, 65: 650V		D : Packaged with fast recovery diode
120: 1200V		R : RC IGBT
		L: Ultra low switching, recommended frequency ~2kHz;
		Q: Low switching, recommended frequency 2~20kHz;
		S: Standard frequency, recommended frequency 5~40kHz;
		F: Fast switching, recommended frequency 10~60kHz;
		UF: Ultra fast switching, recommended frequency 40kHz~.

ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SGT75T65SDM1P4	TO-247-4L	75T65SDM1	Pb free	Tube

ABSOLUTE MAXIMUM RATINGS (T_C=25°C UNLESS OTHERWISE NOTED)

Characteristics		Symbol	Ratings	Units
Collector to Emitter Voltage		V _{CE}	650	V
Gate to Emitter Voltage		V _{GE}	±20	V
Transient Gate to Emitter Voltage (t _p ≤10μs, D<0.010)		V _{GE}	±30	V
Collector Current	T _C =25°C	I _C	150	A
	T _C =100°C		75	
Pulsed Collector Current		I _{CM}	300	A
Diode Current	T _C =25°C	I _F	150	A
	T _C =100°C		75	
Diode forward peak surge current		I _{FSM}	300	A
Short-circuit time(V _{GE} =15V, V _{CC} =300V)		T _{SC}	10	μs
Maximum Power Dissipation (T _C =25°C)		P _D	416	W
Operating Junction Temperature		T _J	-55~+150	°C
Storage Temperature Range		T _{stg}	-55~+150	°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance, Junction to Case (IGBT)	R _{θJC}	--	--	--	0.30	°C/W
Thermal Resistance, Junction to Case (FRD)	R _{θJC}	--	--	--	0.65	°C/W
Thermal Resistance, Junction to Ambient (IGBT)	R _{θJA}	--	--	--	40	°C/W
Soldering Temperature (in line)	T _{sold}	15 ⁺² ₋₀ sec, 1time	--	--	260	°C

ELECTRICAL CHARACTERISTICS OF IGBT (T_C=25°C, UNLESS OTHERWISE NOTED)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Units	
Collector to Emitter Breakdown Voltage	BV _{CE}	V _{GE} =0V, I _C =250μA	650	--	--	V	
C-E Leakage Current	I _{CES}	V _{CE} =650V, V _{GE} =0V	--	--	200	μA	
G-E Leakage Current	I _{GES}	V _{GE} =20V, V _{CE} =0V	--	--	±400	nA	
G-E Threshold Voltage	V _{GE(th)}	I _C =250μA, V _{CE} =V _{GE}	4.0	5.0	7	V	
Collector to Emitter Saturation Voltage	V _{CE(sat)}	I _C =75A, V _{GE} =15V, T _C =25°C	--	1.65	--	V	
		I _C =75A, V _{GE} =15V, T _C =125°C	--	1.90	--	V	
Input Capacitance	C _{ies}	V _{CE} =30V V _{GE} =0V f=1MHz	--	4200	--	pF	
Output Capacitance	C _{oes}		--	300	--		
Reverse Transfer Capacitance	C _{res}		--	83	--		
Turn-On Delay Time	T _{d(on)}	V _{CE} =400V I _C =75A R _g =10Ω V _{GE} =15V Inductive load T _C =25°C	--	55	--	ns	
Rise Time	T _r		--	42	--		
Turn-Off Delay Time	T _{d(off)}		--	210	--		
Fall Time	T _f		--	90	--		
Turn-On Switching Loss	E _{on}		Inductive load T _C =25°C	--	1.07	--	mJ
Turn-Off Switching Loss	E _{off}			--	1.70	--	
Total Switching Loss	E _{st}			--	2.77	--	
Turn-On Delay Time	T _{d(on)}		V _{CE} =400V I _C =37.5A R _g =10Ω V _{GE} =15V inductive load T _C =25°C	--	43	--	ns
Rise Time	T _r			--	24	--	
Turn-Off Delay Time	T _{d(off)}			--	230	--	
Fall Time	T _f	--		48	--		
Turn-On Switching Loss	E _{on}	inductive load T _C =25°C		--	0.40	--	mJ
Turn-Off Switching Loss	E _{off}			--	0.88	--	
Total Switching Loss	E _{st}			--	1.28	--	
Total Gate Charge	Q _g	V _{CE} =400V, I _C =75A, V _{GE} =15V		--	180	--	nC
Gate to Emitter Charge	Q _{ge}			--	40	--	
Gate to Collector Charge	Q _{gc}			--	80	--	

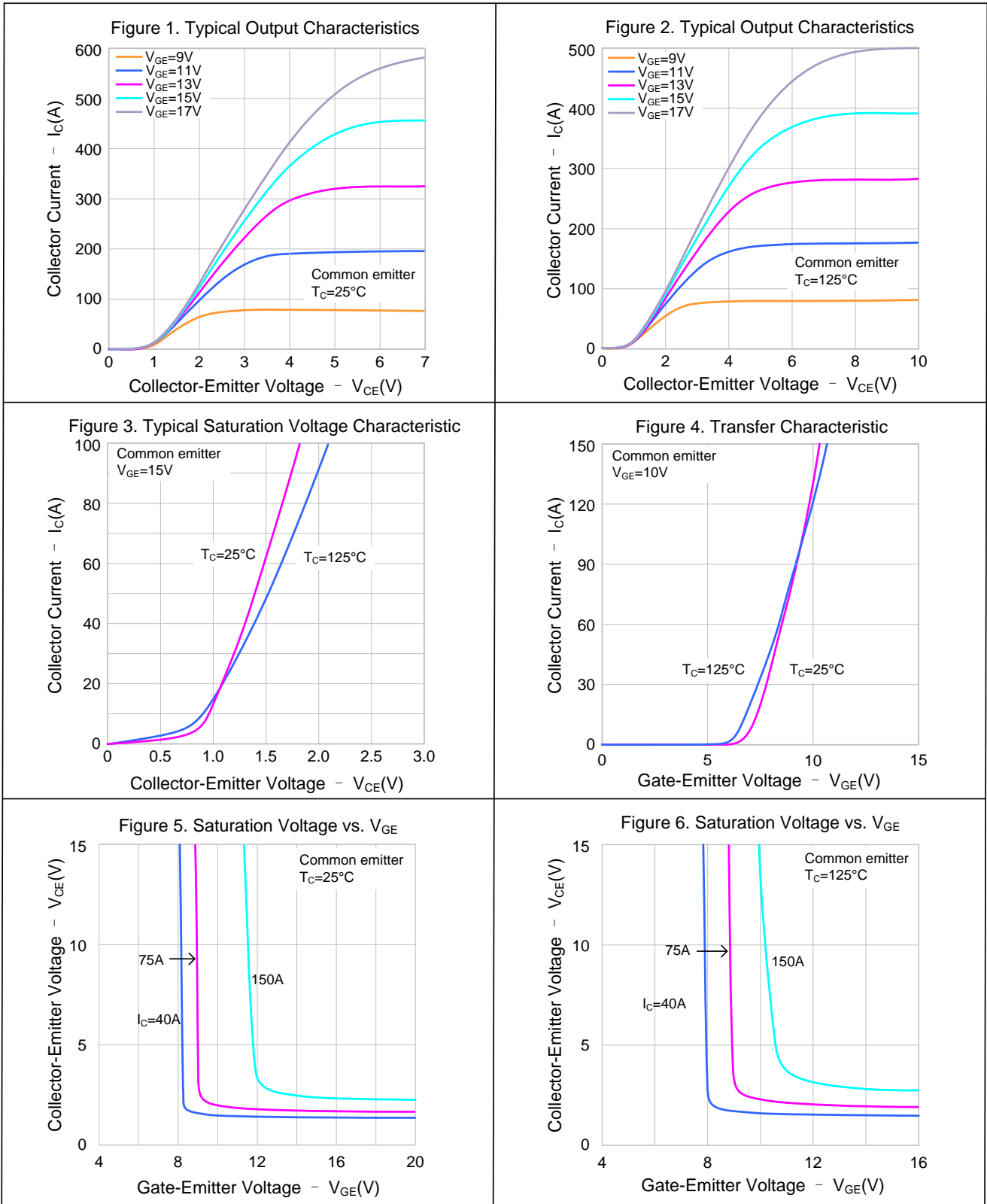
ELECTRICAL CHARACTERISTICS OF FRD (T_C=25°C UNLESS OTHERWISE NOTED)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Units
Diode Forward Voltage	V _{FM}	I _F =75A, T _C =25°C	--	1.82	2.3	V
		I _F =75A, T _C =125°C	--	1.52	--	
Diode Reverse Recovery Time	T _{rr}	I _{EC} =75A, dI _{EC} /dt=200A/μs	--	45	--	ns
Diode Reverse Recovery Charge	Q _{rr}	I _{EC} =75A, dI _{EC} /dt=200A/μs	--	135	--	nC

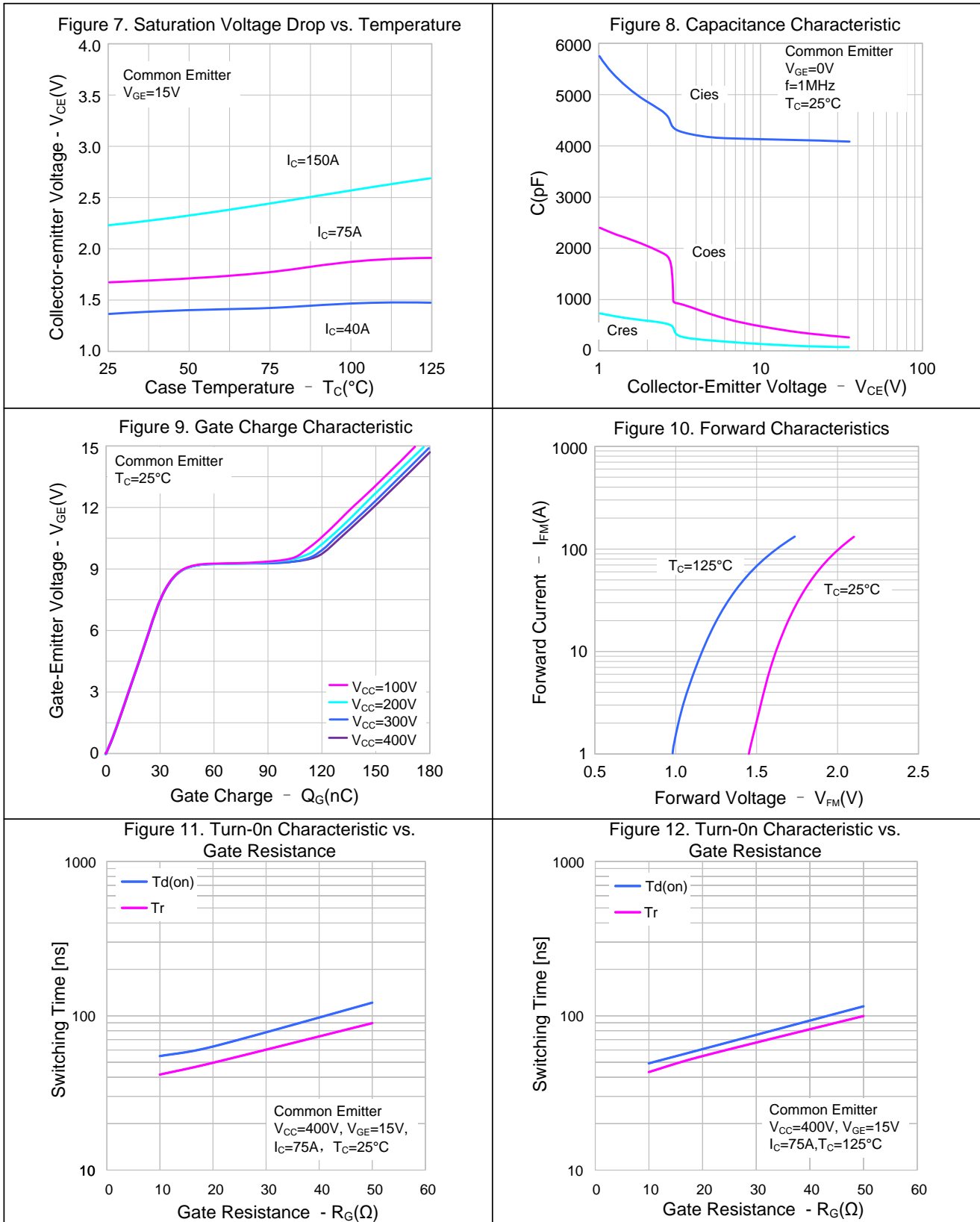
ELECTRICAL CHARACTERISTICS OF IGBT (T_C=125°C)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Units
Turn-On Delay Time	T _{d(on)}	V _{CE} =400V I _C =75A R _g =10Ω V _{GE} =15V	--	49	--	ns
Rise Time	T _r		--	43	--	
Turn-Off Delay Time	T _{d(off)}		--	232	--	
Fall Time	T _f		--	117	--	
Turn-On Switching Loss	E _{on}	inductive load T _C =125°C	--	1.28	--	mJ
Turn-Off Switching Loss	E _{off}		--	2.45	--	
Total Switching Loss	E _{st}		--	3.73	--	
Turn-On Delay Time	T _{d(on)}	V _{CE} =400V I _C =37.5A R _g =10Ω V _{GE} =15V	--	51	--	ns
Rise Time	T _r		--	28	--	
Turn-Off Delay Time	T _{d(off)}		--	264	--	
Fall Time	T _f		--	125	--	
Turn-On Switching Loss	E _{on}	inductive load T _C =125°C	--	0.47	--	mJ
Turn-Off Switching Loss	E _{off}		--	1.47	--	
Total Switching Loss	E _{st}		--	1.94	--	

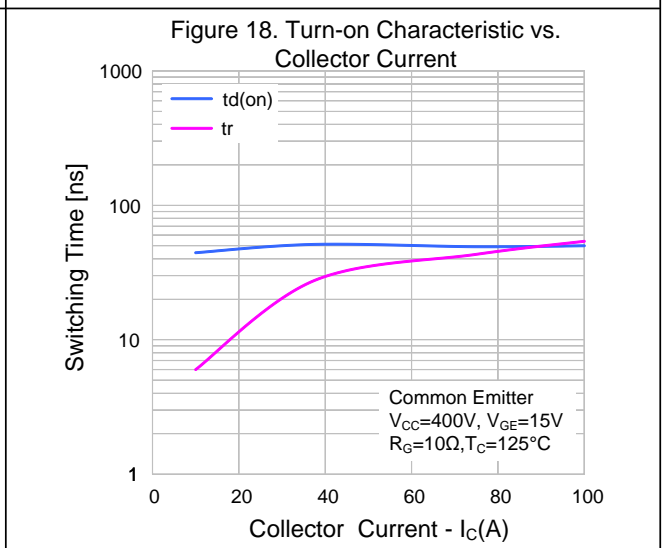
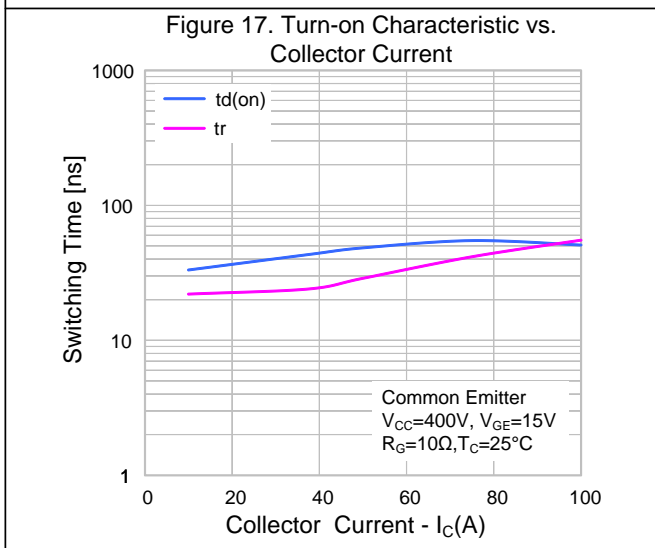
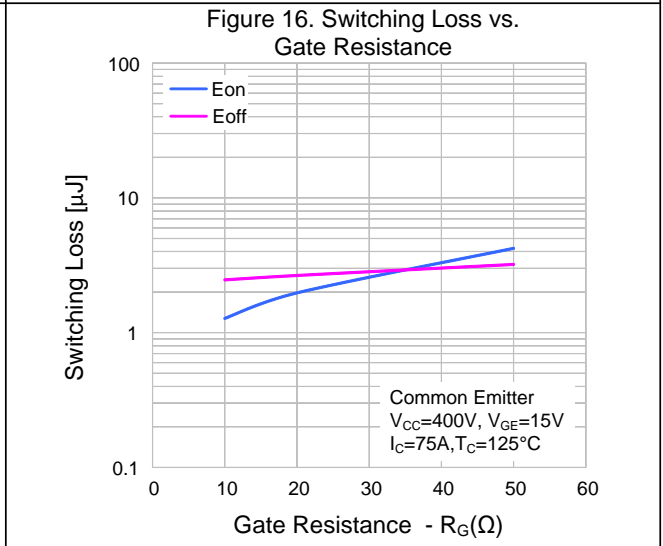
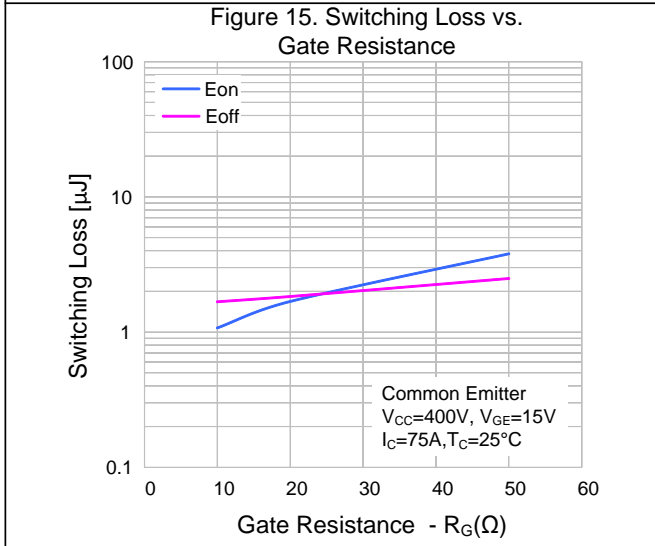
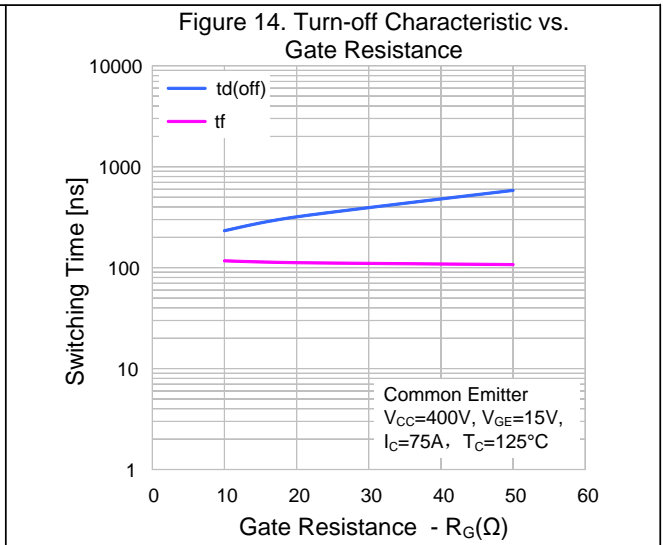
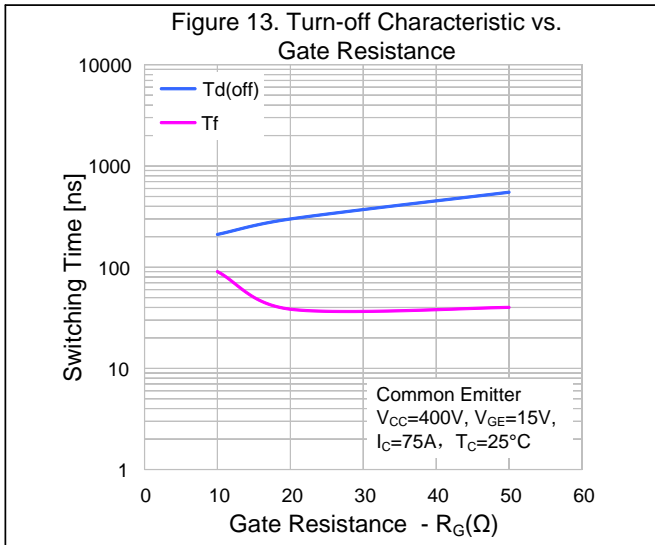
TYPICAL CHARACTERISTICS CURVE



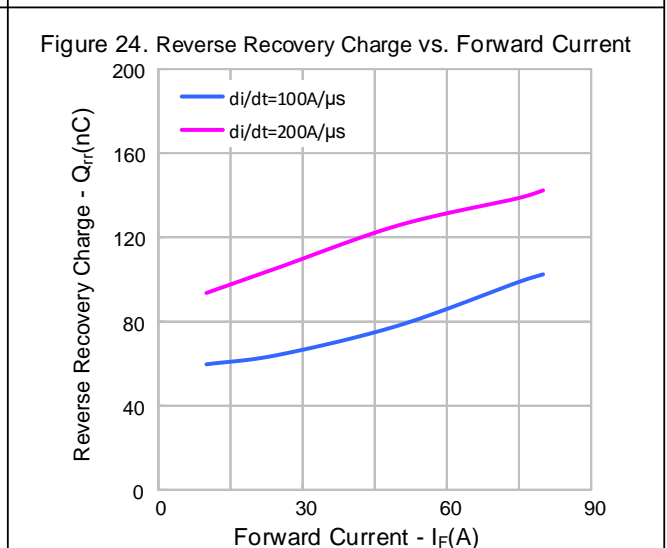
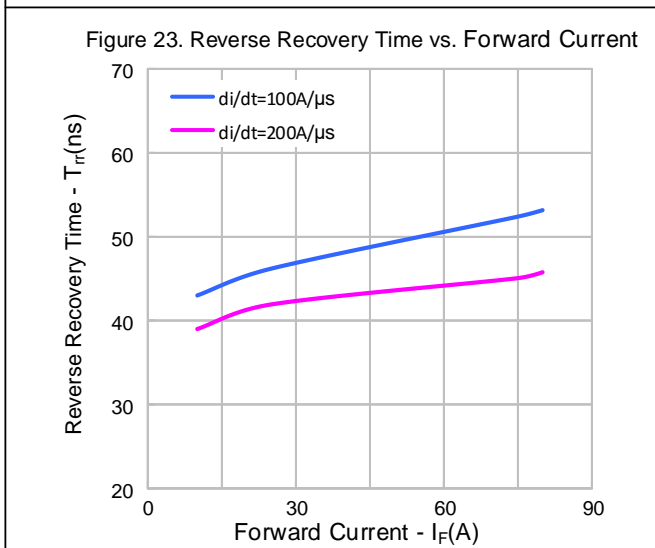
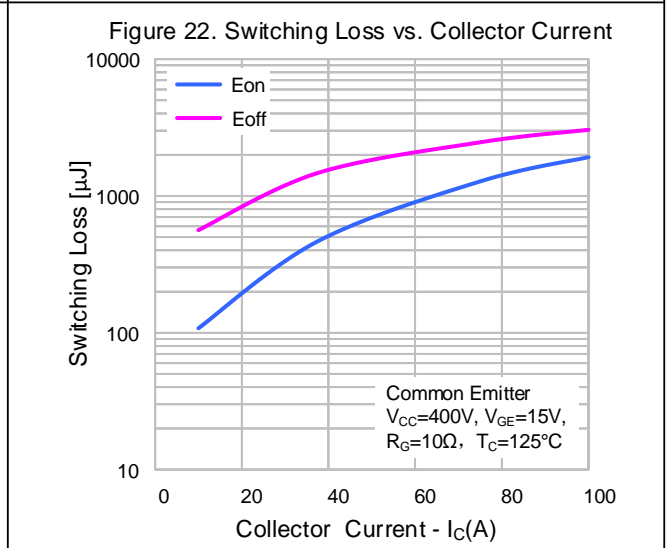
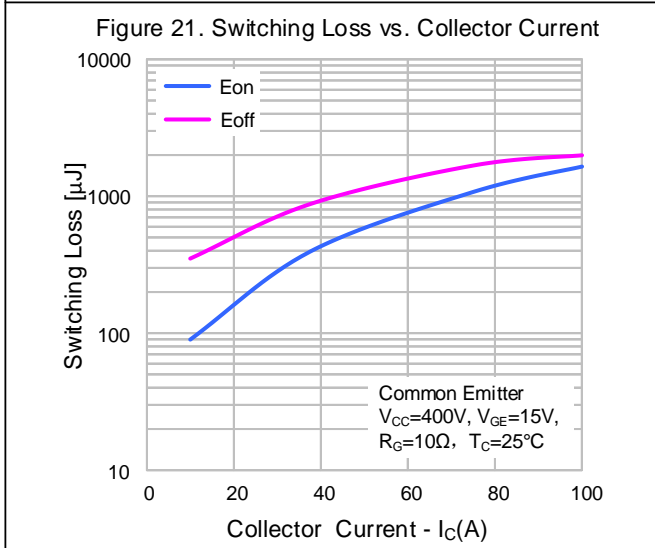
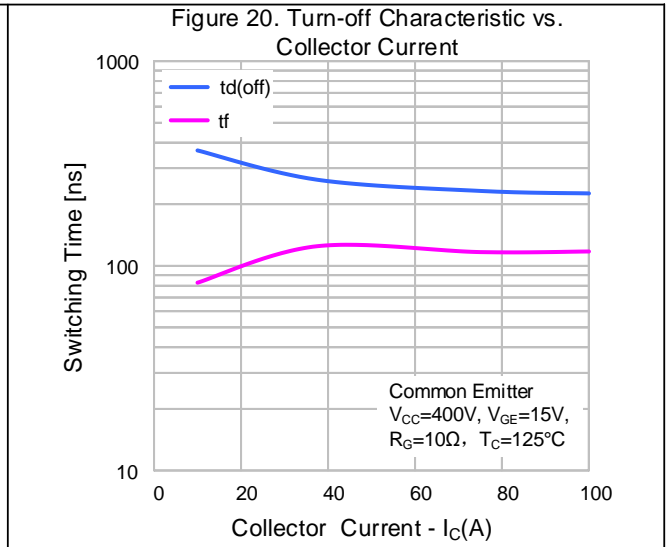
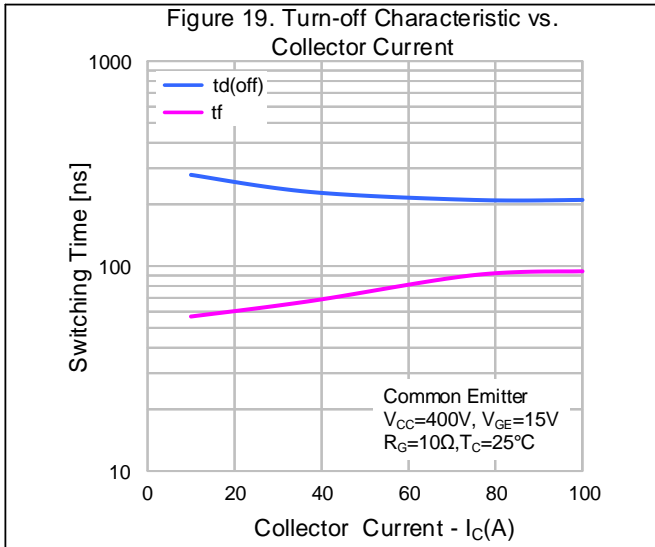
TYPICAL CHARACTERISTICS CURVE (CONTINUED)



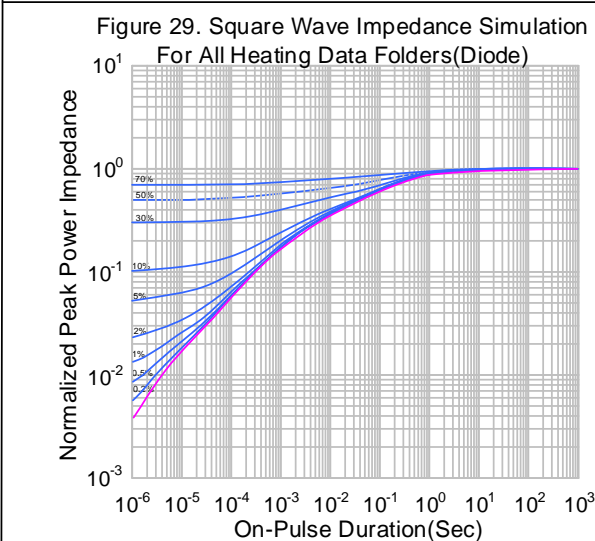
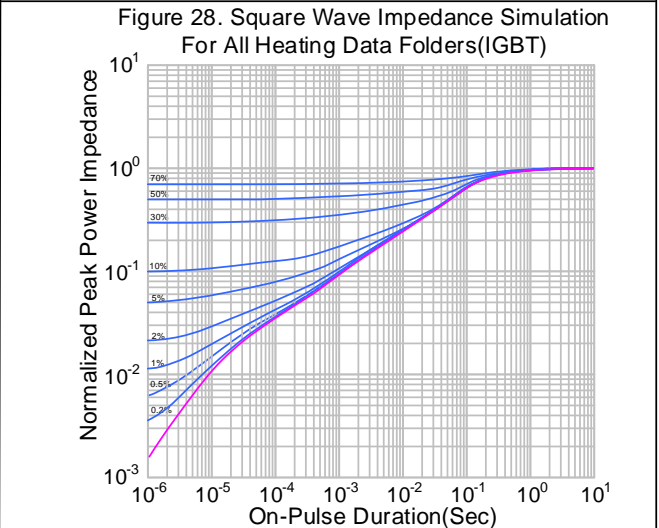
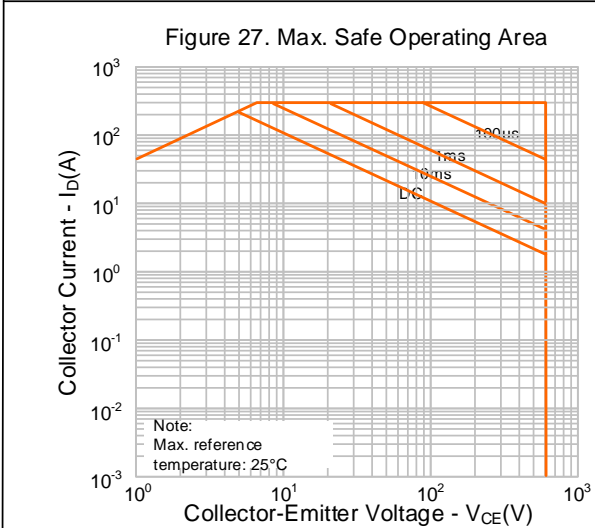
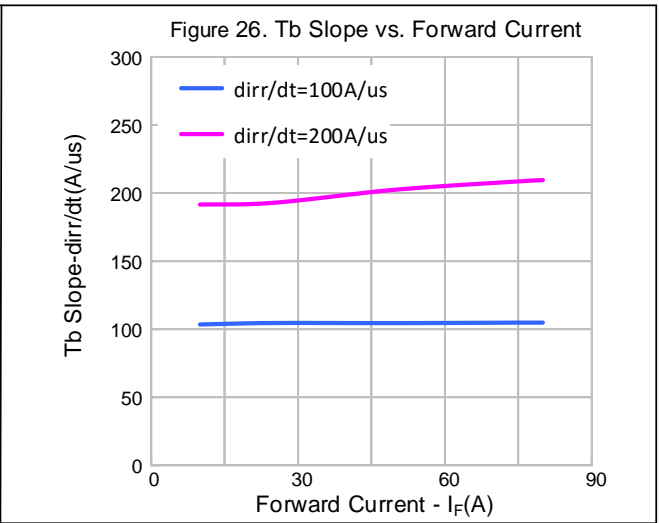
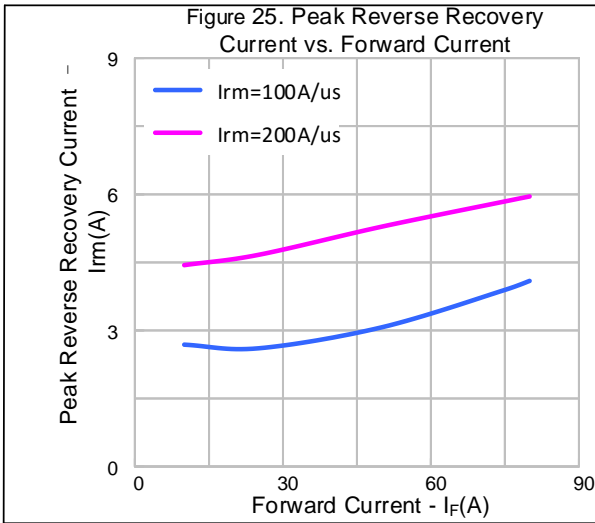
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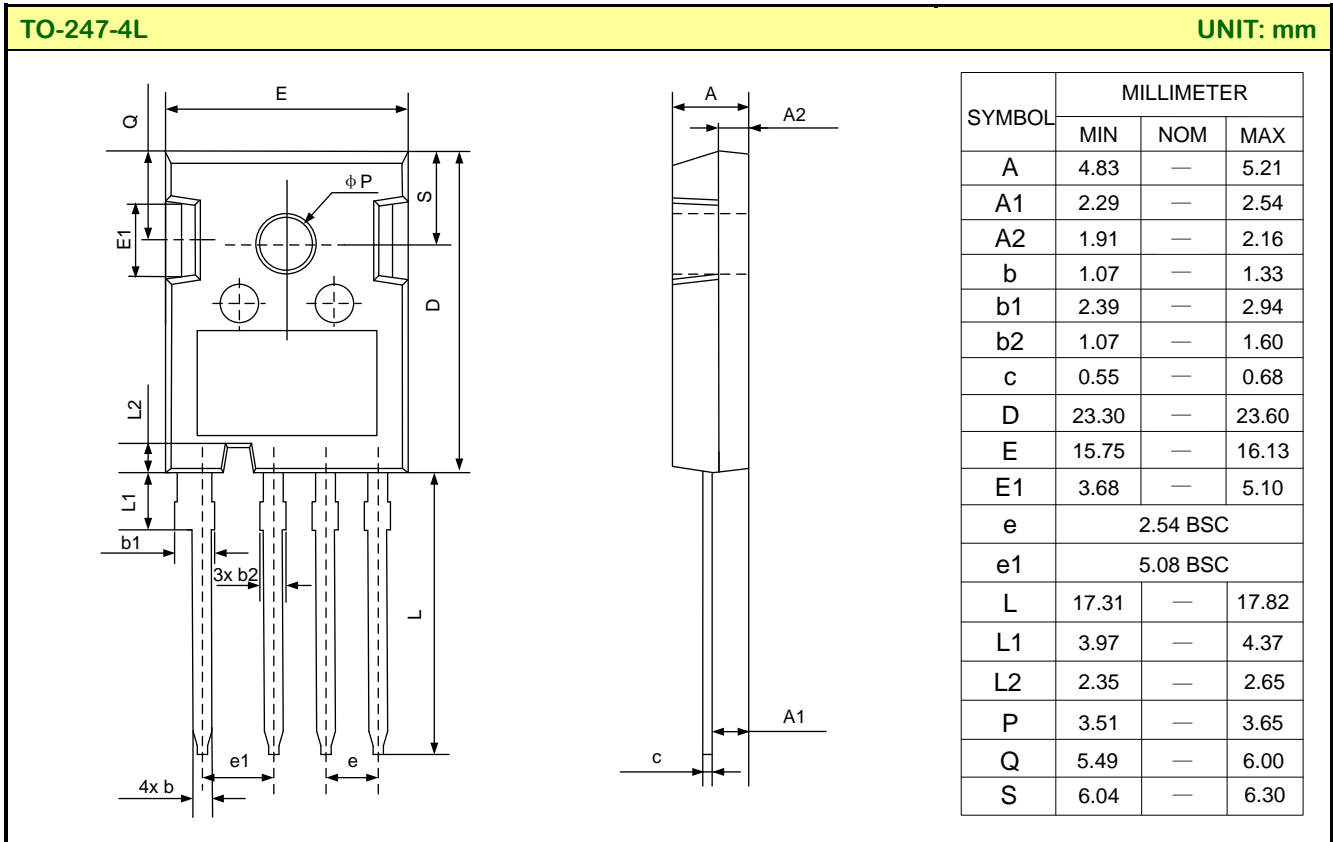
TYPICAL CHARACTERISTICS CURVE (CONTINUED)



TYPICAL CHARACTERISTICS CURVE (CONTINUED)



PACKAGE OUTLINE



Important notice :

1. The instructions are subject to change without notice !
2. Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current. Please read the instructions carefully before using our products, including the circuit operation precautions.
3. Our products are consumer electronic products or the other civil electronic products.
4. When using our products, please do not exceed the maximum rating of the products, otherwise the reliability of the whole machine will be affected. There is a certain possibility of failure or malfunction of any semiconductor product under specific conditions. The buyer is responsible for complying with safety standards and taking safety measures when using our products for system design, sample and whole machine manufacturing, so as to avoid potential failure risk that may cause personal injury or property loss.
5. It is strongly recommended to identify the trademark when buying our products. Please contact us if there is any question.
6. Product promotion is endless, our company will wholeheartedly provide customers with better products!
7. Website: <http://www.silan.com.cn>

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Rev.: 1.3

Revision History:

1. Add I_F when $T_C=25^\circ\text{C}$
 2. Update figures 23 and 24, Add figures 25 and 26
-

Rev.: 1.2

Revision History:

1. Add V_{GE}
 2. Modify and add electrical characteristics when $T_C=25^\circ\text{C}$
 3. Add electrical characteristics of IGBT when $T_C=125^\circ\text{C}$
 4. Update typical characteristics curve
-

Rev.: 1.1

Revision History:

1. Update Datasheet
-

Rev.: 1.0

Revision History:

1. First release
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